

Search Notes

Application/Control No.

10/601,372

Examiner

Winnie Yip

Applicant(s)/Patent under
Reexamination

DONAHEY ET AL.

Art Unit

3636

SEARCHED

Class	Subclass	Date	Examiner
52	223.1 223.6- 223.8	10/27/2006	WSY
	223.13		
	223.14		
	125.1		
	309.4		
	309.7		
	309.11 426		
	439 404.1		
	404.2		
	404.5		
	745.21		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Searched in EAST	10/27/2006	